

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Not for submission under 37 CFR 1.99)

Application Number	10629302
Filing Date	2003-07-28
First Named Inventor	Lewis B. Aronson
Art Unit	2613
Examiner Name	Dzung D. Tran
Attorney Docket Number	15436.247.2.1.4

U.S. PATENTS

Examiner Initials*	Cite No.	Patent Number	Issue Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
1	4489477		1984-12-25	Chik et al	
2	6977517		2005-12-20	Miao et al	
3	7019548		2006-03-28	Miao et al	
4	7477847		2009-01-13	Hofmeister et al.	
5	6466886		2002-10-15	Marmur	

U.S. PATENT APPLICATION PUBLICATIONS

Examiner Initials*	Cite No.	Publication Number	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
1	20040076114		2004-04-22	Miriello	

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Foreign Patent Document	Country Code	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T 1
1	2005006575	WO		2005-01-20	Finisar Corp		<input type="checkbox"/>
2	1503232	EP		2004-07-27	Emcore Corp		
3	2004135106	JP		2004-04-30	Hitachi Ltd		
4	224406	TW		2004-11-21	Hon Hai Prec Ind Co Ltd		
5	555297	TW		2003-09-21		Could not obtain copy	

FOREIGN OFFICE ACTION / NOTICE OF ALLOWANCE DOCUMENTS

Examiner Initials*	Cite No.	Application Number	Mail Date	Document
1				

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NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published	T ¹
1	1	HAWTHORNE: "850nm Proton VCSEL Reliability Study" Technical Publications and Application Notes, Advances Optical Components (Finisar Corp), Issue 2, September 2001, pgs 1-7, Richardson, TX	<input type="checkbox"/>
2	2	MECHERLE G S ET AL: "Considerations for Accelerated Laser Diode Life Testing" Proceedings of the Spie, Spie, Bellingham, VA, vol. 717, 1986, pgs 53-62	
3	3	TEBBI O ET AL: "Comparitive study of accelerated testing models, applications in mechanics" 2001 IEEE International Conference on Systems Man and Cybernetics SMC 2001. Tucson, AZ Oct 7-10, 2001, IEEE International Conference on Systems, Man and Cybernetics, New York, NY: IEEE, US, vol 1 of 5 Oct 7, 2001 pgs 2099-2104	
4	4	J.D. BARRY ET AL.: "Thermally Accelerated Life Testing of Single Mode, Double-Heterostructure, AlGaAs Laser Diodes Operated Pulsed at 50 mW Peak Power" IEEE Journal of Quantum Electronics, vol. 21, no. 4 December 25, 1984 pgs 365-376	

OFFICE ACTION / NOTICE OF ALLOWANCE DOCUMENTS

Examiner Initials*	Cite No.	Application Number	Mail Date	Document
1	11118172	2008-09-04	Office Action	
2	10629301	2008-04-01	Office Action	
3	11073452	2008-08-07	Office Action	
4	11118172	2008-03-25	Office Action	
5	11073452	2007-12-31	Office Action	
6	10629301	2008-11-26	Office Action	
7	10884334	2009-01-16	Office Action	
8	10884334	2008-07-10	Office Action	
9	10626965	2007-01-24	Office Action	
10	10626965	2007-08-09	Office Action	
11	10420027	2007-12-12	Office Action	
12	10629228	2008-01-03	Office Action	
13	10626965	2008-03-18	Office Action	
14	10697395	2008-05-30	Office Action	
15	10420027	2008-06-25	Office Action	
16	10884334	2008-01-31	Office Action	

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EXAMINER SIGNATURE

Examiner Signature

Date Considered

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through a citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Applicant is to place a check mark here if English language translation is attached.